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	Application/Control No.	Applicant(s)/Pate	nt Under		
	10/017,759	Reexamination SHIH ET AL.			
	Examiner	Art Unit			
	Satva B Sastri	1713	Page 1 of 1		

Notic of R ferenc s Cited

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-5,744,540	04-1998	Baumstark et al.	524/558
	В	US-4,629,663	12-1986	Brown et al.	428/343
	С	US-			
	D	US-			
	E	US-			
	F	US-		·	
	G	US-		·	
	н	US-			
	1	US-			
	J	US-			
	к	US-			
	L	US-		·.	
	М	US-			·····

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
*	7	WO 9904981 A1	02-1999	World Intellect	SHIH et al.	B41M 05/00
	0					
	Ρ					
	α					
	R					
	· s					
	Т					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)				
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	x					

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.